New Jersey Semi-Conductor Products, Inc.

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2N6904

N-Channel Logic Level Power MOS Field-Effect Transistors (L² FET)

8 A, 200 V

r_{DS}(on): 0.6 Ω

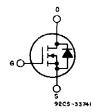
Features:

- Design optimized for 5 volt gate drive
- Can be driven directly from Q-MOS, N-MOS, TTL Circuits
- Compatible with automotive drive requirements
- SOA is power-dissipation limited
- Nanosecond switching speeds
- Linear transfer characteristics
- High input impedance
- Majority carrier device

The 2N6904 is an n-channel enhancement-mode silicongate power MOS field-effect transistor specifically designed for use with logic level (5 volt) driving sources in applications such as programmable controllers, automotive switching, and solenoid drivers. This performance is accomplished through a special gate oxide design which provides full rated conduction at gate biases in the 3-5 volt range, thereby facilitating true on-off power control directly from logic circuit supply voltages.

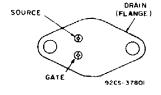
The 2N6904 is supplied in the JEDEC TO-204AA steel package.

N-CHANNEL ENHANCEMENT MODE



TERMINAL DIAGRAM

TERMINAL DESIGNATION



JEDEC TO-204AA

MAXIMUM RATINGS, Absolute Maximum Values (Tc = 25°C):

* DRAIN-SOURCE VOLTAGE, VDSS	200 V
* DRAIN-GATE VOLTAGE (R _{se} ≠ 1 MΩ), Vosa	200 V
* GATE-SOURCE VOLTAGE, Vos	±10 V
* DAIN CURRENT, RMS Continuous, in	. 8A
DAIN CURRENT, HMS Continuous, Ib	20 4
Pulsed, Iom	······
* POWER DISSIPATION, Pt	75.14
At T _c = 25°C	
Above Tc = 25° C, Derate Linearly	0,6 W/°C
* OPERATING AND STORAGE TEMPERATURE, Th. Tang	
LEAD TEMPERATURE. TO	
At distance ≥ 1/8 in. (3.17 mm) from seating plane for 10 s max	



NJ Semi-Conductors reserves the right to change test conditions, parameter limits and package dimensions without notice. Information furnished by NJ Semi-Conductors is believed to be both accurate and reliable at the time of going to press. However, NJ Semi-Conductors assumes no responsibility for any errors or omissions discovered in its use. NJ Semi-Conductors encourages customers to verify that datasheets are current before placing orders.

Quality Semi-Conductors

2N6904

ELECTRICAL CHARACTERISTICS at Case Temperature ($T_c = 25^{\circ}$ C) unless otherwise specified

			LIMITS		
CHARACTERISTIC		TEST CONDITIONS	MIN.	MAX.	UNITS
Drain-Source Breakdown Voltage	BVoss	l _D = 1 mA, V _{GS} = 0	200	-	v
Gate Threshold Voltage	Vas(th)	V _{Gs} = V _{Ds} , I _D = 1 mA	1	2	v
Zero Gate Voltage Drain Current	loss	V _{DS} = 160 V	_	1	
		T _c = 125°C, V _{DS} = 160 V	_	50	μΑ
Gate-Source Leakage Current	IGSS	$V_{GS} = \pm 10 \text{ V}, \text{ V}_{DS} = 0$		100	nA
Drain-Source On Voltage	V _{DS} (on) ^a	I _D = 5.1 A, V _{G8} = 5 V		3.06	- v
		I _D = 8 A, V _{GS} = 5 V		5.5	
Static Drain-Source On Resistance	ros(On)@	I _D = 5.1 A		0.6	
		Tc=125° C, Ip=5.1 A, Vgs=5 V	***	1.11	Ω
Forward Transconductance	gn a	V _{DS} = 5 V, I _D = 5.1 A	3	12	mhó
Input Capacitance	Ciss	V _{DS} = 25 V	350	900	
Output Capacitance	Cose	V _{G8} = 0 V	75	250	pF
Reverse-Transfer Capacitance	Cras	f = 0.1 MHz	20	100	
Turn-On Delay Time	t _d (on)	V _{DD} = 100 V	_	45	
Rise Time	t,	lo = 5.1 A		150]
Turn-Off Delay ⊺ime	t₀(off)	R _{gen} = R _{gs} = 15 Ω		135	ns
Fall Time	tr	V _{as} = 5 V		150]
Thermal Resistance Junction-to-Case	R _{Øjc}		<u> </u>	1.67	°C/W

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

	CHARACTERISTIC			LIMITS		
			TEST CONDITIONS	MIN.	MAX.	UNITS
•	Diode Forward Voltage	Vsp	I _{SD} = 8 A	0.8	1.6	v
Γ	Reverse Recovery Time	t _{rr}	I _F = 4 A	_	625	ns
			$d_{IF}/d_t = 100 \text{ A}/\mu \text{s}$			

* In accordance with JEDEC registration data.

^aPulsed: Pulse duration = 300 µs, max., duty cycle = 2%.